



ALTERNATIVE TO PTO/SB/08A/B (09/06)

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Complete if Known		
			Application Number	10/713,729	
			Filing Date	November 13, 2003	
			First Named Inventor	Bruce W. MCGAUGHY	
			Art Unit	2128	
Examiner Name	D. Silver				
Sheet	1	of	1	Attorney Docket Number	188122001700

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/D.S./	1.	US-2003/0237067-A1	12-25-2003	Mielke et al.	
	2.	US-2004/0078767-A1	04-22-2004	Burks et al.	
	3.	US-4,942,536-A	07-17-1990	Watanabe et al.	
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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY			

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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²	
	15.	Chakrabarti, D.R. et al. (November 23-24, 1995). "An Improved Hierarchical Test Generation Technique for Combinational Circuits with Repetitive Sub-circuits," <i>Proceedings of the Fourth Asian Test Symposium 1995</i> , 1:237-243.		
	16.	Jones et al. (February 1994). "A Cache-Based Method for Acceleration Switch-Level Simulation," <i>IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems</i> 13(2).		
	17.	Stanford.edu. "Radix 2 FFT Complexity is N Log N," <u><i>In Mathematics of the Discrete Fourier Transform (DFT) with Music and Audio Application</i></u> . Smith, III, J.O. (2003). W3K Publishing: Stanford, located at < http://ccma.stanford.edu/~jos/mdft/Radix_2_FFT_Complexity.html >, 1 page.		
	18.	Wong, Y. (1985). "Hierarchical Circuit Verification," <i>IEEE 22nd Design Automation Conference</i> .		

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Examiner Signature	/David Silver/ (02/01/2008)	Date Considered	
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